Search Notes



10/573,702

Examiner

BINH Q. TRAN

Applicant(s)/Patent under Reexamination

MIYASHITA, SHIGEKI

Art Unit

3748

	SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST TEXT SEARCHED	2/21/2007	вт		
INVENTOR SEARCHED	2/21/2007	ВТ		
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